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| Notice of References Cited | Application/Control No. 10/807,520 | Applicant(s)/Patent Under Reexamination OIKAWA ET AL. | |
| | Examiner Mary A. El-Shammaa | Art Unit 2883 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|---------------|----------------|
| | A | US-5,717,803 | 02-1998 | Yoneda et al. | 385/89 |
| | B | US-5,848,210 | 12-1998 | Kimura, Naoki | 385/89 |
| | C | US-6,477,284 | 11-2002 | Oda et al. | 385/14 |
| | D | US-6,829,079 | 12-2004 | Oda et al. | 359/318 |
| | E | US-6,934,448 | 08-2005 | Akashi et al. | 385/49 |
| | F | US-2003/0053765 | 03-2003 | Oda et al. | 385/88 |
| | G | US-2003/0123805 | 07-2003 | Akashi et al. | 385/49 |
| | H | US-2005/0089282 | 04-2005 | Oikawa et al. | 385/092 |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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